

THE DIAMOND LIGHT SOURCE CONTROL SYSTEM INTERFACE TO THE LIBERA ELECTRON BEAM POSITION MONITORS

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Abstract

Libera Electron Beam Position Monitors (EBPMs) used at Diamond provide information about the electron beam position at a variety of frequency scales from 10 MHz, through revolution frequency, down to 10 Hz. Diamond Light Source has implemented an EPICS interface to Libera integrating all of this information into the overall control system. In conjunction with the timing and fast orbit feedback interfaces this provides access to the rich data sets and functionality provided by Libera. The details of the interfaces and available data, both directly from the Libera and through a concentrator, are described here.

LIBERA SYSTEM OVERVIEW

Diamond Light Source uses 168 Electron Beam Position Monitors (EBPMs) in the storage ring, together with 22 in the booster and 7 in each of the two transfer paths, to monitor the position of the electron beam.

Each EBPM consists of a button block in the vacuum vessel with four pickup electrodes surrounding the electron beam; these pick up electric fields corresponding to the electron beam position as modulations of the machine RF ($f_{RF} \approx 499.65$ MHz). The four button signals are fed by coaxial cables to a Libera[1] EBPM processor where the amplitudes of the signals are processed and used to compute the electron beam position, as shown in figure 1.

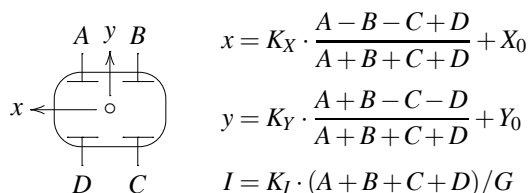


Figure 1: Computing electron beam position x, y and current I from measured button intensities A, B, C, D , scaling factors K_X, K_Y determined by button geometry, offsets X_0, Y_0 measured by beam based alignment, current scaling K_I dynamically calibrated against a DCCT, and the currently programmed RF gain G .

Libera processes these signals in three stages: RF board, FPGA, and embedded controller. In the RF board the four signals pass through a cross-bar switch into four parallel analogue channels where the signal is amplified with programmable gain and band-pass filtered to approximately 10 MHz around f_{RF} before being undersampled by ADCs at around 117 MHz (sample frequency f_S). The sampling frequency is carefully chosen to both place the intermediate frequency (IF) close to $\frac{1}{4}f_S$ and avoid, as far as possible, the

folding back of IF and machine revolution ($f_R = f_{RF}/936$) harmonics onto the intermediate frequency.

The raw sampled signal is processed by a Virtex-II Pro FPGA with firmware developed by the manufacturer, Instrumentation Technologies (I-Tech), with some modifications by Diamond. In the FPGA the raw signal is first demultiplexed according to the cross-bar switch setting and phase and amplitude corrected to compensate for channel differences before being mixed with a digital local oscillator to bring the intermediate frequency down to DC: this involves the conversion of button signals to quadrature I, Q values. These signals are filtered by repeated stages of digital down conversion to reduce the sample frequencies to the values provided by Libera, as below.

$f_S \approx 117$ MHz (bandwidth 10 MHz). Fixed length 1024 point waveforms of raw ADC button signals captured on trigger are useful for first turn and transfer path position measurement.

$f_R \approx 534$ kHz. A circular buffer of two seconds of turn-by-turn data is stored, from which triggered waveforms of at least one second of turn-by-turn position data can reliably be provided. Waveforms are read from this buffer on every trigger, and the same buffer is read on postmortem trigger.

$f_{FA} \approx 10$ kHz. Electron beam positions are generated at approximately 10 kHz and used for beam position validation (machine protection interlock) and are transmitted to the Fast Feedback network[2]. This is the Fast Acquisition (FA) data stream.

$f_{SA} \approx 10$ Hz. Beam positions at approximately 10 Hz can be handled directly by EPICS clients as scalars and are made available as 10 Hz updates over Ethernet. This is the Slow Acquisition (SA) data stream.

The turn-by-turn data stream can also be decimated by the FPGA by a factor of 64 on readout; this is useful for cycling machines such as the Diamond booster, where a complete ramp can be returned as a 3,000 point waveform.

The FA data stream is available via the fast feedback network; the remaining signals are processed by the final part of the system, the embedded controller.

SYSTEM SOFTWARE

For its control system interface Libera uses an ARM XScale PXA 255 processor running at 400 MHz with 32 MB flash and 64 MB RAM. There is no hardware floating point support: this must be allowed for during software development. The software on the controller consists of embedded Linux and a kernel device driver,

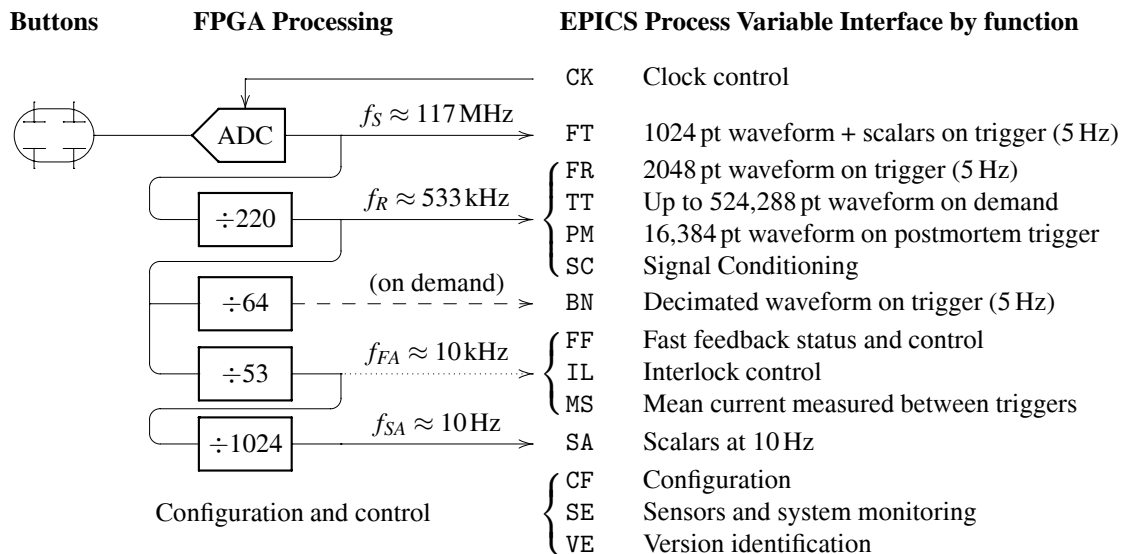


Figure 2: Overview of Libera system with data processing chains and associated groups of PVs. The two letter function code is part of the PV name, for example SR01C-DI-EBPM-01:SA:X names an SA PV on the first storage ring Libera.

both provided by I-Tech, together with Diamond developed processes adding EPICS functionality and supplementing or replacing I-Tech’s original software[3].

The direct software interface to the FPGA on Libera consists of device nodes provided by the kernel driver, and some directly accessed registers. The control interface to Libera is provided by the EPICS driver which provides a complete interface to all of the functionality available from Libera and hides the kernel driver and registers. Data access and control is provided via Process Variables¹, a fundamental notion in any EPICS controller.

The EPICS driver provides around 500 PVs grouped into 14 major functions as shown in figure 2. The system software is structured as three daemons: clock control, temperature control, and an EPICS IO controller (IOC).

Clock Control

The ADC sample clock is maintained at a precise ratio of the machine revolution clock frequency via a voltage controlled crystal oscillator (VCXO) and a phase measurement circuit in the FPGA which counts sample clocks every 53,382 revolution clocks, roughly every 100ms.

Stability of the ADC clock is essential for good beam position measurement: the clock daemon is able to maintain the phase of the sample clock to within ± 1.5 samples against the machine clock; this is sufficient for stable position measurement and synchronisation.

The sample clock is maintained at a frequency close to an integer fraction of the revolution clock (220 samples per revolution, versus 936 electron bunches per revolution).

¹An EPICS Process Variable (PV) is typically a single numerical value, or a fixed length waveform, with a fixed name which can be read or written by any remotely connected EPICS Channel Access client. The naming convention for PVs is an important part of controller design.

However, if f_s is precisely 220 samples per revolution then beating with harmonics of revolution sidebands is seen in the filtered beam position, so it is necessary to “detune” the sample clock; at Diamond the frequency offset is approximately 4 kHz.

The clock controller is also important for the fast feedback communication network which requires all Liberias to be synchronously clocked (to within a microsecond or so). Synchronisation is done via a global trigger, and the clock controller checks for loss of synchronisation.

Position Measurements

The EPICS driver processes the button intensity data and computes positions from both raw ADC rate data and filtered turn-by-turn waveforms. For speed of computation the calculation of button magnitudes from I, Q values is performed using the CORDIC[4] algorithm, and a specialised fast division routine using Newton-Raphson was written to accelerate position calculation.

For “first turn” (FT) or transfer path position measurement the raw ADC waveform is frequency shifted and filtered in software, and a user defined window defines the region of interest from which a scalar position is calculated.

Two triggers are used for turn-by-turn waveform capture: a global system trigger, normally fired on injection into the storage ring every 200ms, and a postmortem trigger fired on loss of machine protection interlock. Postmortem data is very valuable in diagnosing causes of beam loss.

Three groups of PVs are used for turn-by-turn data: FR and BN PVs update on every trigger returning fixed length waveforms, while the TT PVs provide variable length triggered waveform capture designed for machine physics applications. The postmortem PM group also returns turn-by-turn data.

Signal Conditioning

The beam position calculation is very sensitive to small variations in the measured signal: disturbing the coaxial button cables can move the measured position by microns. In particular, drifting and instabilities in the four analogue channels in the RF board cause high levels of lower frequency noise. This is compensated in Libera via an RF cross-bar which ensures that each button signal is passed, in turn, through each filter and amplifier chain on the RF board; the final measured button signal is then an average of the four channels.

This switching process largely eliminates low frequency drift in measured position, but at the cost of high levels of noise at the switching frequency. At Diamond switching occurs every 40 turns with a complete cycle of switching every 320 turns (Diamond's RF boards require 8 switch positions), resulting in a lowest switching frequency of 1.67 kHz. Careful filter design plus a pair of notch filters removes most of this switching noise from FA and SA data, but it is important to reduce the impact of switching.

One source of noise is the different phase and gain of each analogue channel. This can be modelled as a complex scaling factor K_c for each channel c , so the measured signal with the cross-bar switch in position n passing button b through channel $p(n,b)$ is $Z_{n,b} = K_{p(n,b)}X_b$. By measuring \bar{Z} for all button positions and channels (a 2048 point turn-by-turn waveform is ample for this measurement) the input signal \bar{X} can be estimated by averaging over all switch positions, assuming that the input signal is constant during measurement, and from this the error \bar{K} can be computed². By working with complex gains and signals, phase and gain can be compensated together at the sampled intermediate frequency.

The Diamond EPICS driver performs this calculation every few seconds during normal operation and updates a two point FIR filter for each channel to perform the correction, and also provides all the measurements as PVs. Monitoring the signal conditioning PVs can provide very helpful information about the health of the RF board.

Interlocks and Monitoring

Within the FPGA the 10 kHz data stream is used as a beam position interlock to protect against mis-steering of the stored beam: when the stored beam is more than 10 mA the beam is confined to a window of ± 1 mm; if this window is exceeded a machine protection interlock is dropped and the beam is dumped.

PVs are provided for monitoring the health of the Libera, and an alarm is indicated if appropriate. Monitors include fan speeds and internal system temperatures, on board voltages, available RAM (including log file consumption) and CPU usage. The health of the clocks is monitored, and loss of synchronisation generates an alarm.

²This is oversimplified, see the code[3] for details. In practice the estimation of \bar{X} requires geometric means of magnitudes and arithmetic means of angles, and K_c also needs to depend on n .

SYSTEM INTEGRATION

All 168 storage ring Liberas are operated together through control scripts, from client applications, or through the "Concentrator": this EPICS server monitors all Liberas, gathers position readings into aggregate waveforms, and manages global functions. The Concentrator further monitors the maximum ADC levels on all Liberas and controls the gain programmed into the RF board to avoid ADC overflow in any Libera. This is done globally to avoid jumps in position from unexpected changes in gain, particularly during fast feedback.

When the beam intensity measurement from all Liberas is averaged the result is a very sensitive beam current measurement with high frequency noise levels well below those of the DCCT used for beam current measurement. By calibrating this average against the more accurate DCCT it is possible to measure very low storage ring injection currents with high precision and sensitivity.

The 10 kHz Fast Acquisition data stream from each Libera passes onto the fast feedback network which communicates real time position data from all attached Liberas to all attached nodes, including fast feedback motor controllers[2]. An extra "sniffer" node is attached to this network and manages a circular buffer of 100,000 samples of beam positions around the ring at 10 kHz which can be read out in blocks via EPICS. Using this tool detailed spectral analysis of full machine beam behaviour can be investigated from 1.5 kHz down to 100 mHz.

CONCLUSIONS

EPICS integration of Libera into the Diamond control system has been successful and Libera operates reliably.

The Diamond Libera EPICS driver has been developed as an open source application under GPL and is available for download from Diamond's web site[3]. This driver is in use at synchrotron light sources in Germany, China and Korea, and is being evaluated for use at NSLS2 in the USA.

Future work on Libera will mostly concentrate on minor changes, but there are two major developments in the pipeline: a new rootfs built from scratch, based on Busybox and a standard Linux kernel, which we'll be deploying to the machine this year; and plans for moving much of the kernel driver into user space to improve maintainability.

REFERENCES

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